

<b>Notice of References Cited</b>	Application/Control No. 10/668,172	Applicant(s)/Patent Under Reexamination PAN ET AL.	
	Examiner Lee Fineman	Art Unit 2872	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0206256 A1	11-2003	Drain et al.	349/113
	B	US-2002/0041441 A1	04-2002	Wang, Ying-Fu	359/599
	C	US-4,729,631	03-1988	Takahashi et al.	359/456
	D	US-6,266,476 B1	07-2001	Shie et al.	385/147
	E	US-5,471,348	11-1995	Miller et al.	359/837
	F	US-5,887,964	03-1999	Higuchi et al.	362/31
	G	US-6,639,725 B2	10-2003	Masaki et al.	359/599
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.